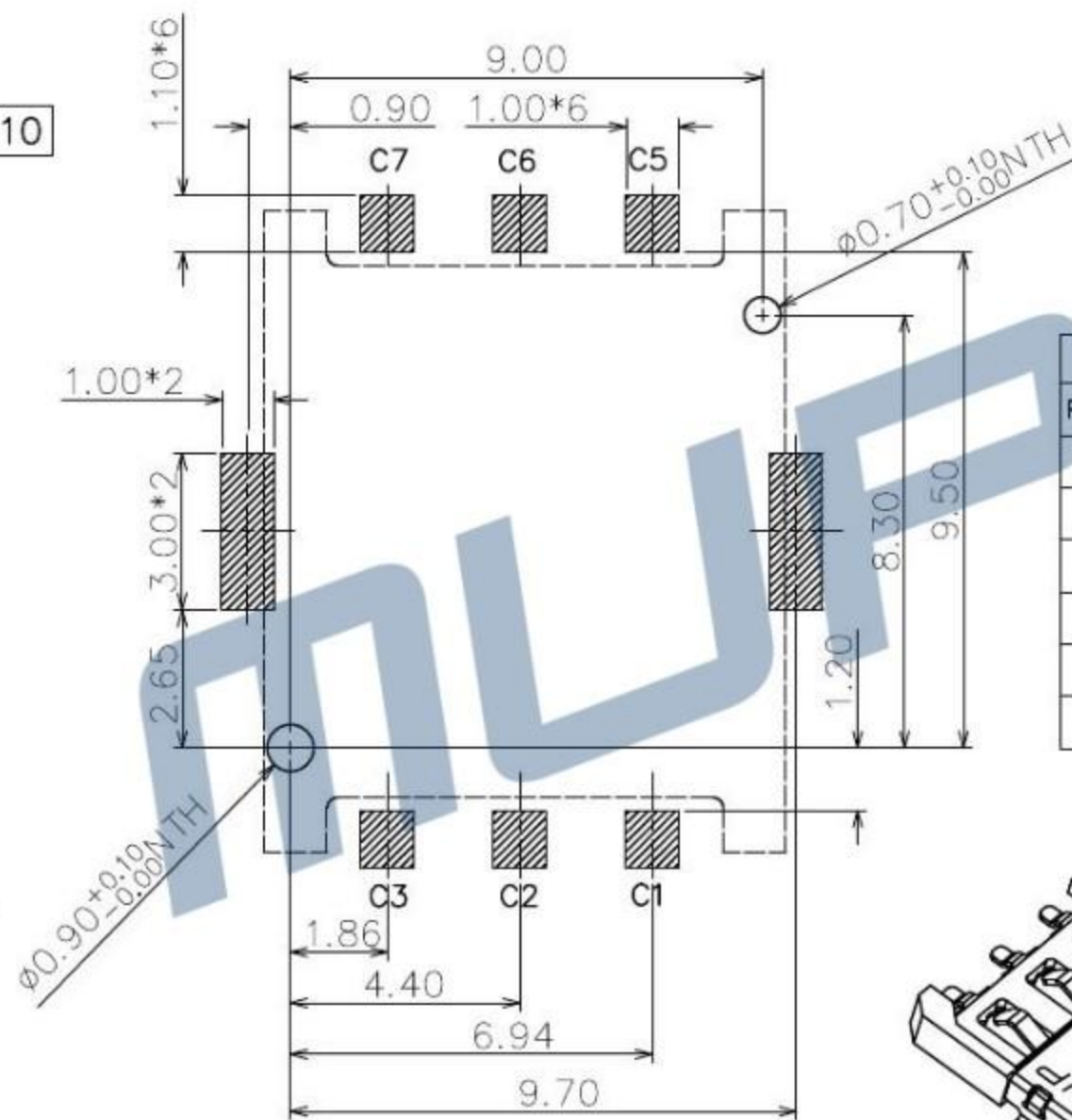
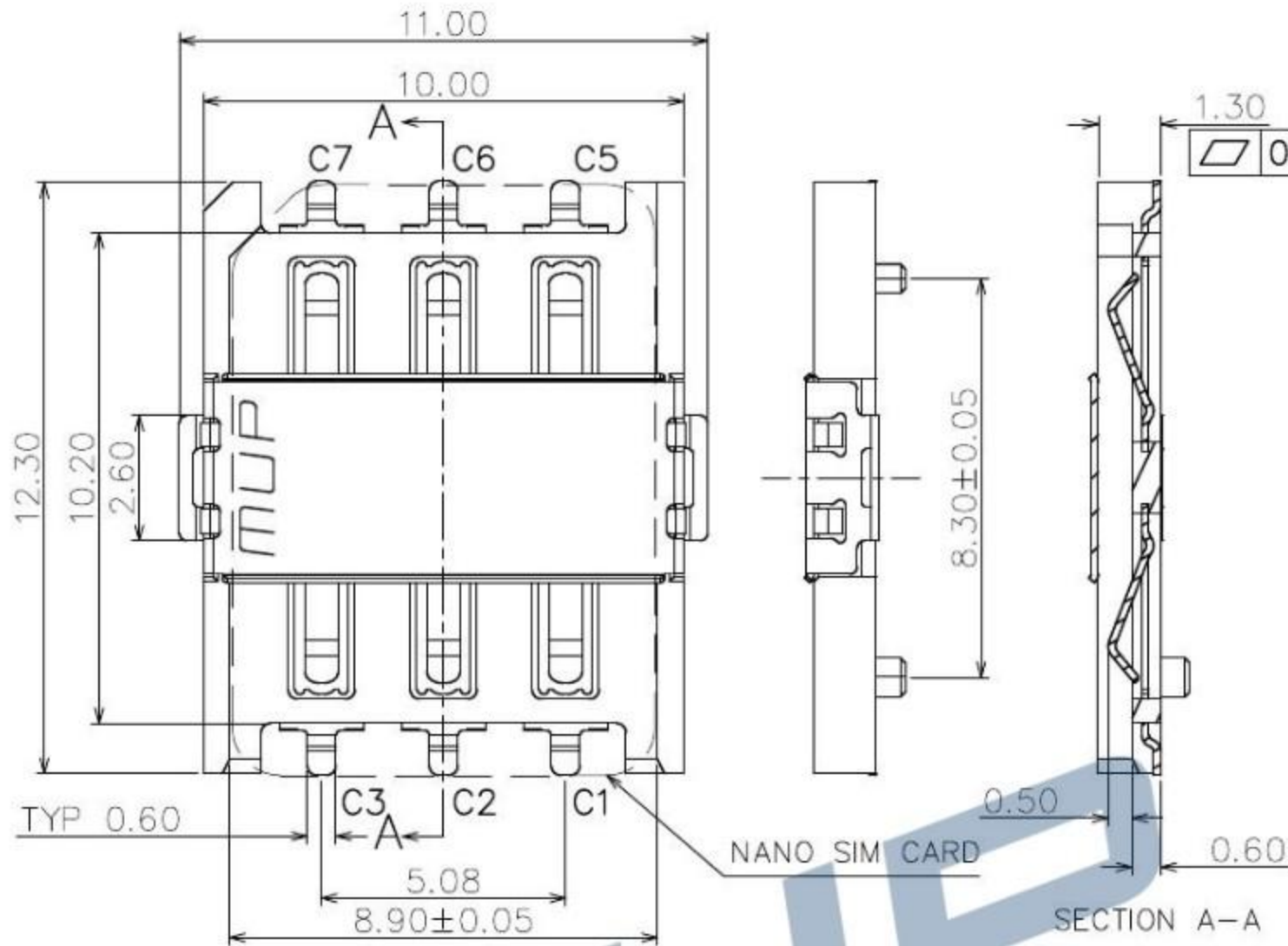
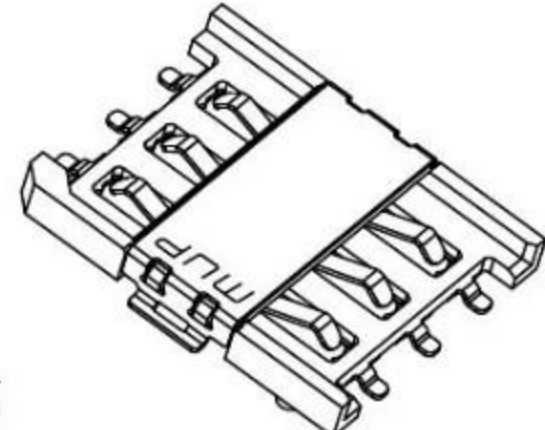


REV.	DESCRIPTION OF REVISIONS	APPR.	DRAW.	RELEASE	DATE
X1	NEW REVISION				Henry Apr.09.2014
X2					



Nano-SIM CARD	
Pin No.	NAME
C1	VCC
C2	RST
C3	CLK
C5	GND
C6	VPP
C7	I/O



RECOMMENDED P.C.B LAYOUT
COMPONENT SIDE(TOLERANCE ± 0.05)

ITEM	PART NAME	Q'TY	MATERIAL	FINISH
1	HOUSING	1	Hi-temp Thermoplastic	Black UL94V-0
2	DATA CONTACT	6	Copper Alloy	Contact area:Gold plated
3	SHELL	1	Stainless Steel	SMT area:Gold plated

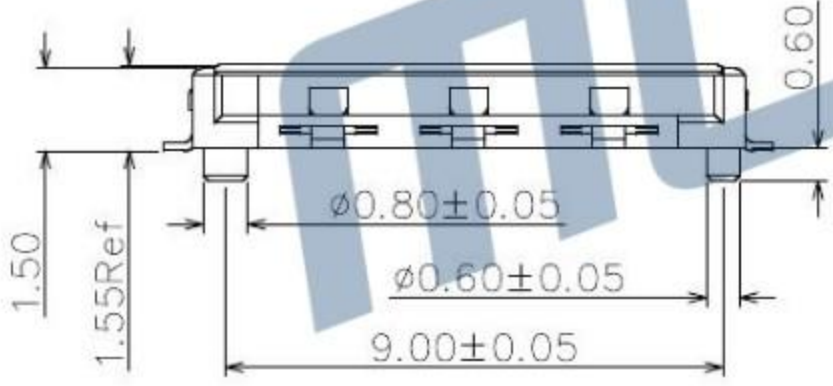
TECHNICAL CHARACTERISTICS

1.General Characteristics
 Dimensions: 12.30LX10.00WX1.50H mm
 Weight: Approx 0.53 \pm 0.2g
 Durability: 1,500 cycles min.

2.Electrical Characteristics
 Contact resistance: 50m Ω typical, 100m Ω max
 Insulation resistance: >1000M Ω /500V DC

3.Solderability
 Vaporphase: 215 $^{\circ}$ C, 30sec.Max
 IR reflow: 250 $^{\circ}$ C, 5sec.Max
 Manual soldering: 370 $^{\circ}$ C, 3sec.Max

4.Environmental Characteristics
 Operating temperature: -40 $^{\circ}$ C~+85 $^{\circ}$ C
 Operating humidity: 10%~+95%RH



Unless otherwise specified, other tolerance are:

X	± 0.35	X*	$\pm 5^{\circ}$
X.X	± 0.25	X.X*	$\pm 4^{\circ}$
X.XX	± 0.15	X.XX*	$\pm 3^{\circ}$
X.XXX	± 0.10	X.XXX*	$\pm 2^{\circ}$

MUP MUP INDUSTRIAL CO.,LTD.

NAME: **Nano-SIM Card Connector**
 MODEL NO: **MUP-C781-1**
 TYPE: **H1.50mm 6 PIN**

PROJ.	UNIT	SCALE	DRAWN	DWG NO.:
	mm	1:1	Henry Apr.09.2014	DWG-MUP-C781-1
CUSTOMER DRAWING			CHECKED	SHEET
			Simon Apr.09.2014	1/1
			APPROVAL	REVISION
				X1

